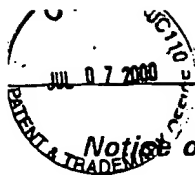


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EXAMINER			DATE				
José R. Díaz			January 4, 2001				
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Applicant(s)

BAWOLEK et al.

Examiner

Allan R. Wilson

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